

### Features

- High Reliability Capability
- Extremely low on-resistance RDS(on)
- Excellent gate charge x RDS(on) product(FOM)

Product Summary			
V <sub>DS</sub>	R <sub>DS(on)</sub> (mΩ) Typ	I <sub>D</sub> (A)	Q <sub>g</sub> (Typ)
40V	1.6 @ 10V 30A	130	168nc

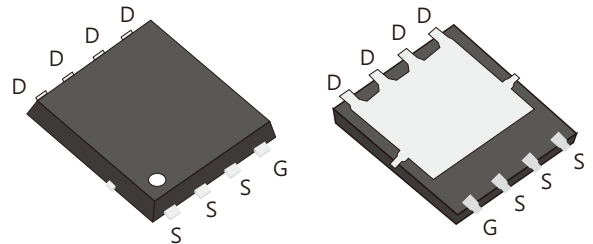
### Mechanical Data

- Case:DFN5×6 Package

DFN5×6  
D019N04G

### Application

- Switching Application
- SR (Synchronous rectification)
- DC/DC converter
- General purpose applications



### Ordering Information

Part No.	Package Type	Package	Quality(box)
D019N04G	DFN5×6	Tape & Reel	5000

### Block Diagram

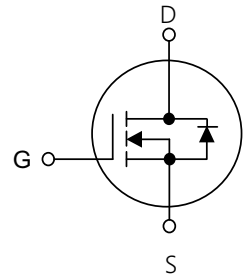


Table1 Absolute Maximum Ratings (T<sub>c</sub>=25°C, unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V <sub>DS</sub>	40	V
Gate-Source Voltage	V <sub>GS</sub>	±20	V
Continuous Drain Current	I <sub>D</sub>	T <sub>c</sub> =25°C	130
		T <sub>c</sub> =100°C	85
Pulsed Drain Current (Note 1)	I <sub>DM</sub>	520	A
Single Pulse Avalanche Energy(Note 2)	E <sub>AS</sub>	900	mJ
Power Dissipation T <sub>c</sub> =25°C	P <sub>D</sub>	78	W
Operating Junction and Storage Temperature	T <sub>J</sub> /T <sub>STG</sub>	-55~+150	°C

**Table 2. Thermal Characteristics**

Parameter	Symbol	Value	Unit
Thermal resistance Junction to Ambient	$R_{\theta JA}$	40	$^{\circ}C/W$
Thermal resistance Junction to Case	$R_{\theta JC}$	1.6	$^{\circ}C/W$

**Table 3. Electrical Characteristics ( $T_J=25^{\circ}C$ , unless otherwise specified)**

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS}=0V, I_D=250\mu A$	40	-	-	V
Drain-Source Leakage Current	$I_{DSS}$	$V_{DS}=40V, V_{GS}=0V$	-	-	1	$\mu A$
Gate- Source Leakage Current	Forward	$V_{GS}=20V, V_{DS}=0V$	-	-	100	nA
	Reverse	$V_{GS}=-20V, V_{DS}=0V$	-	-	-100	nA
On Characteristics(Note 3)						
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	1.0	1.7	2.4	V
Static Drain-Source On-State Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=30A$	-	1.6	1.9	m $\Omega$
Dynamic Characteristics(Note 4)						
Input Capacitance	$C_{ISS}$	$V_{DS}=20V, V_{GS}=0V, f=1MHz$	-	9386	-	pF
Output Capacitance	$C_{OSS}$		-	655	-	pF
Reverse Transfer Capacitance	$C_{RSS}$		-	562	-	pF
Gate Resitance	$R_G$	$V_{DD}=0V, V_{GS}=0V, f=1MHz$	-	1.2	-	$\Omega$
Switching Characteristics (Note 4)						
Turn-On Delay Time	$t_d(on)$	$V_{DS}=20V,$ $V_{GS}=10V, R_L=3.5\Omega,$	-	11	-	ns
Turn-On Rise Time	$t_r$		-	4.6	-	ns
Turn-Off Delay Time	$t_d(off)$		-	32	-	ns
Turn-Off Fall Time	$t_f$		-	6	-	ns
Total Gate Charge	$Q_G$	$V_{DS}=20V, I_D=30A,$ $V_{GS}=10V$	-	168	-	nC
Gate-Source Charge	$Q_{GS}$		-	26	-	nC
Gate-Drain Charge	$Q_{GD}$		-	33	-	nC
Drain-Source Diode Characteristics and Maximum Ratings						
Drain-Source Diode Forward Voltage	$V_{SD}$	$V_{GS}=0V, I_S=50A$	-	-	1.2	V
Maximum Continuous Drain-Source Diode Forward Current	$I_S$		-	-	130	A
Reverse Recovery Time	$t_{rr}$	$V_{GS}=0V, I_F=20A$ $dI_F/dt=500A/\mu s$	-	44	-	ns
Reverse Recovery Charge	$Q_{RR}$		-	47	-	nC

Notes : 1 Repetitive Rating:Pulse width limited by maximum junction temperature

2  $L=0.5mH, R_G=25\Omega, V_{DS}=48V, Starting T_J=25^{\circ}C$

3 Pulse Test: Pulse width  $\leq 300\mu S$ , Duty cycle  $\leq 2\%$

4 Guaranteed by design, not subject to production

Typical Characteristics Diagrams

Figure 1. Output Characteristics

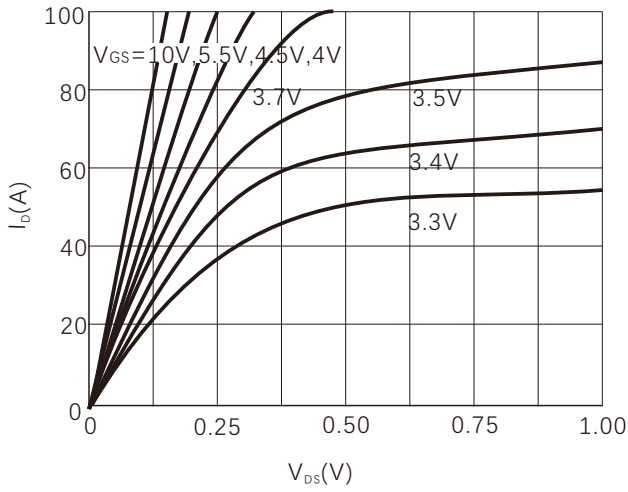


Figure 2. Threshold Voltage

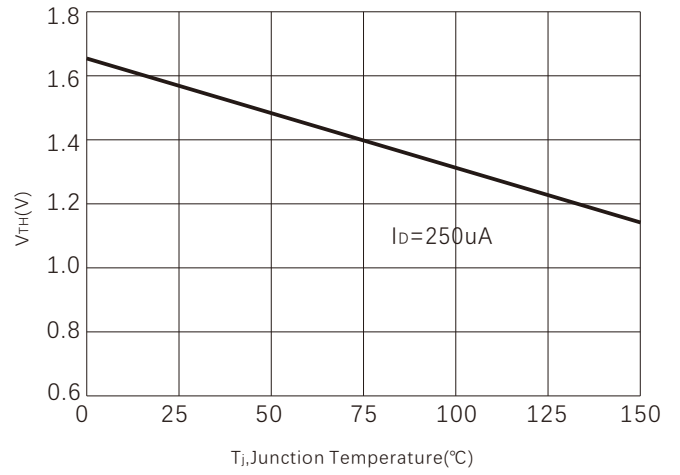


Figure 3. On-Resistance vs. Drain Current

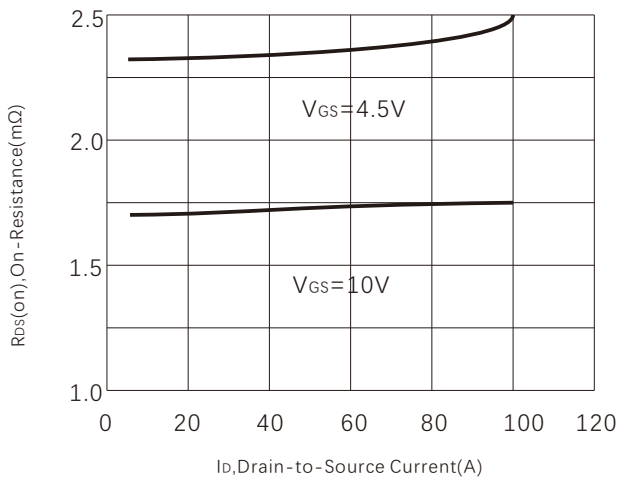


Figure 4. Capacitance

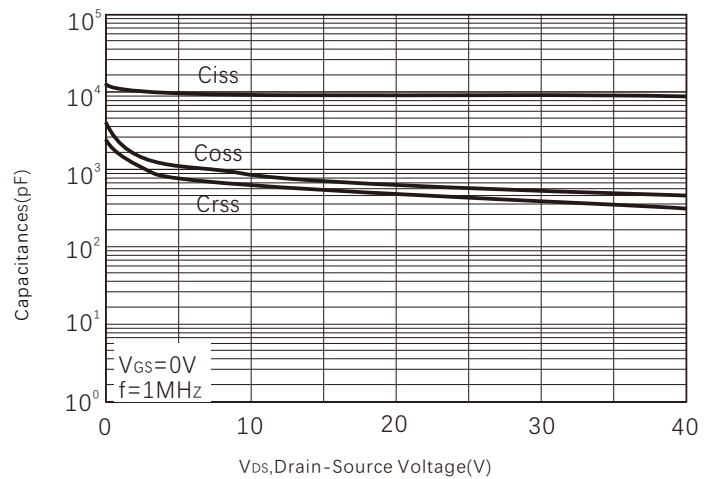


Figure 5. On-Resistance vs. Gate-Source Voltage

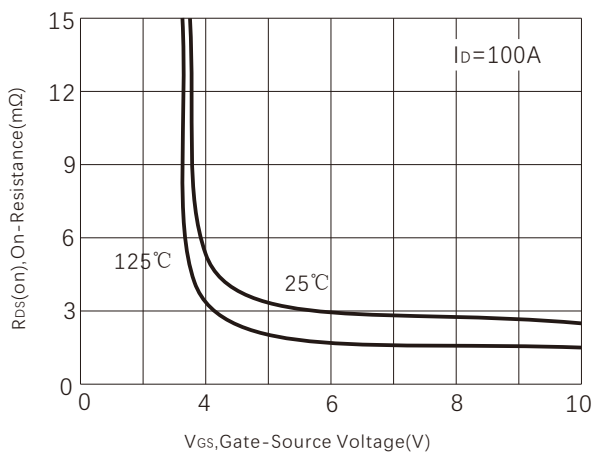


Figure 6. Source-Drain Diode Forward Voltage

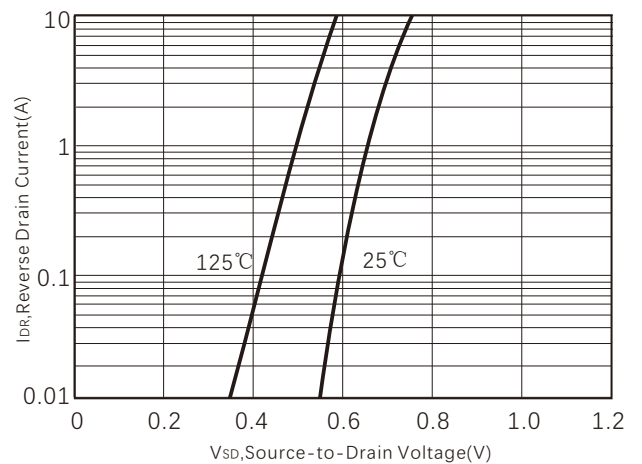


Figure 7. Maximum Drain Current vs Temperature

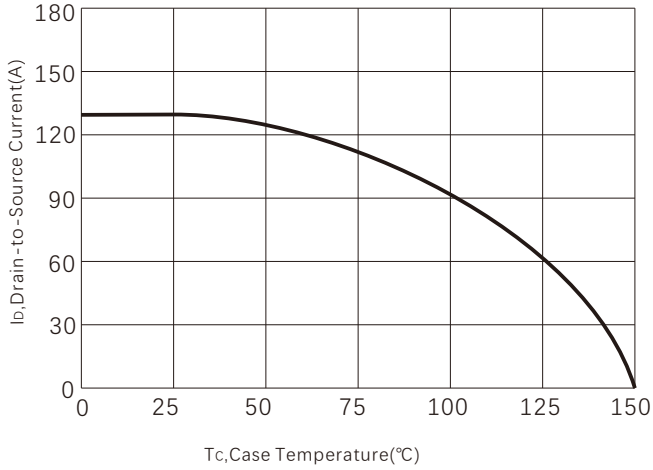


Figure 8. Transfer Characteristics

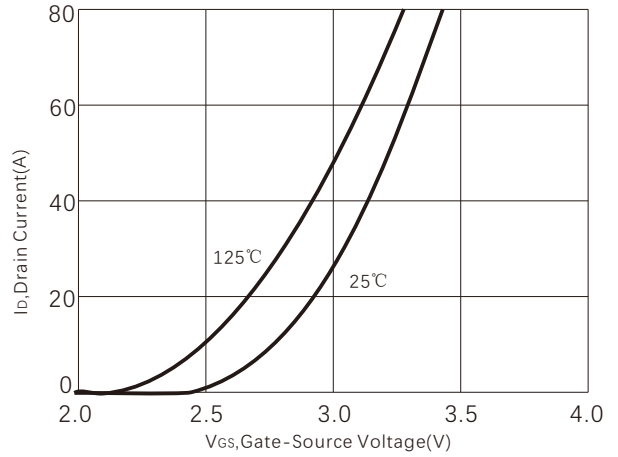


Figure 9. Safe operating area

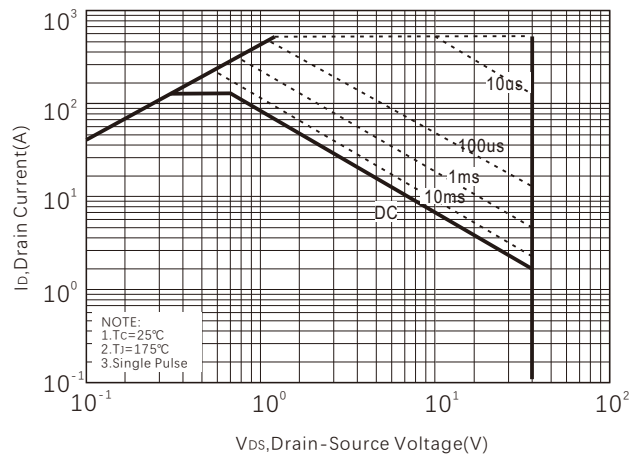
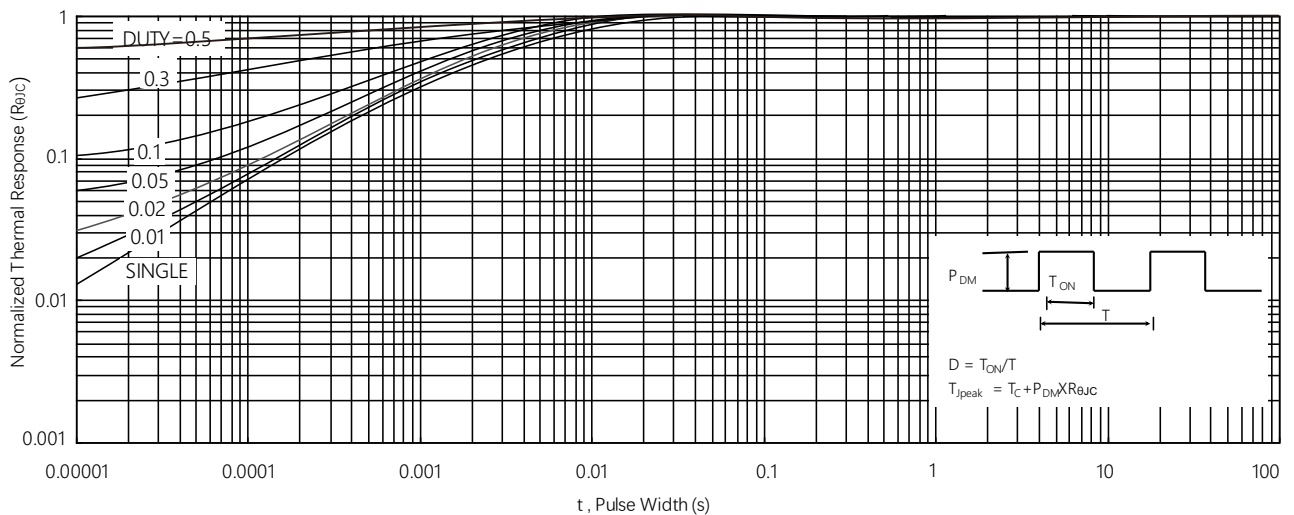
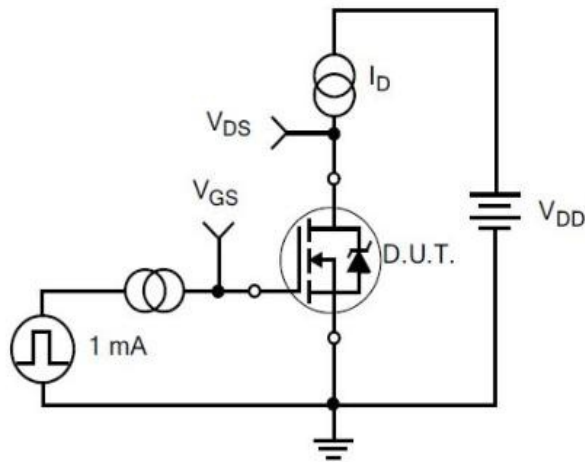


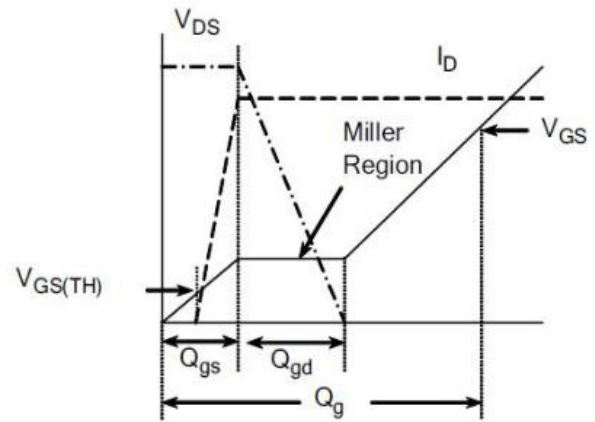
Figure 10. Normalized Maximum Transient Thermal Impedance



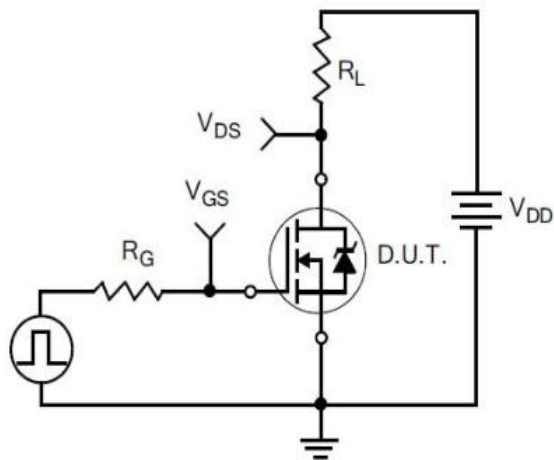
Typical Test Circuit



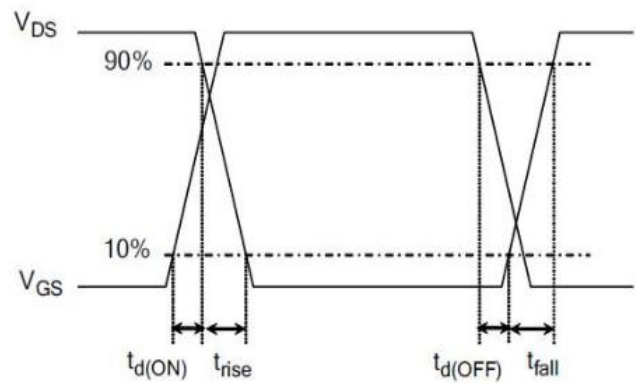
1) Gate Charge Test Circuit



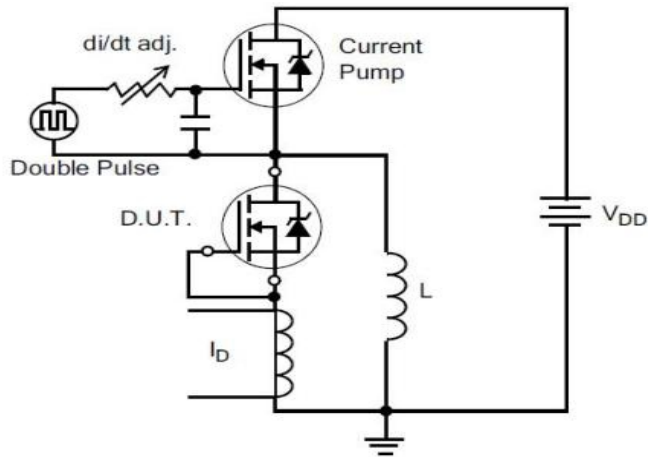
2) Gate Charge Waveform



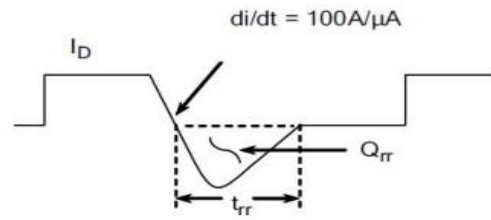
3) Resistive Switching Test Circuit



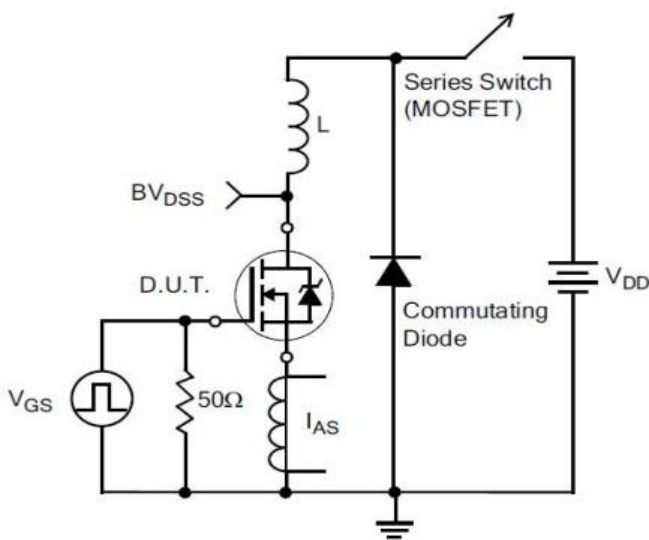
4) Resistive Switching Waveforms



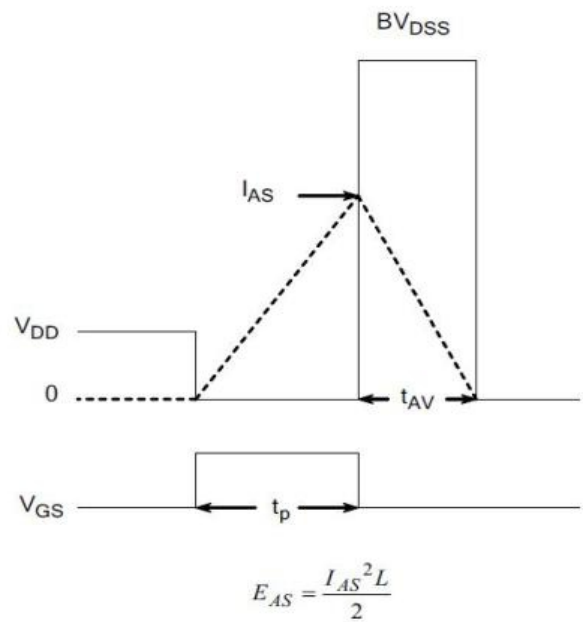
5) Diode Reverse Recovery Test Circuit



6) Diode Reverse Recovery Waveform



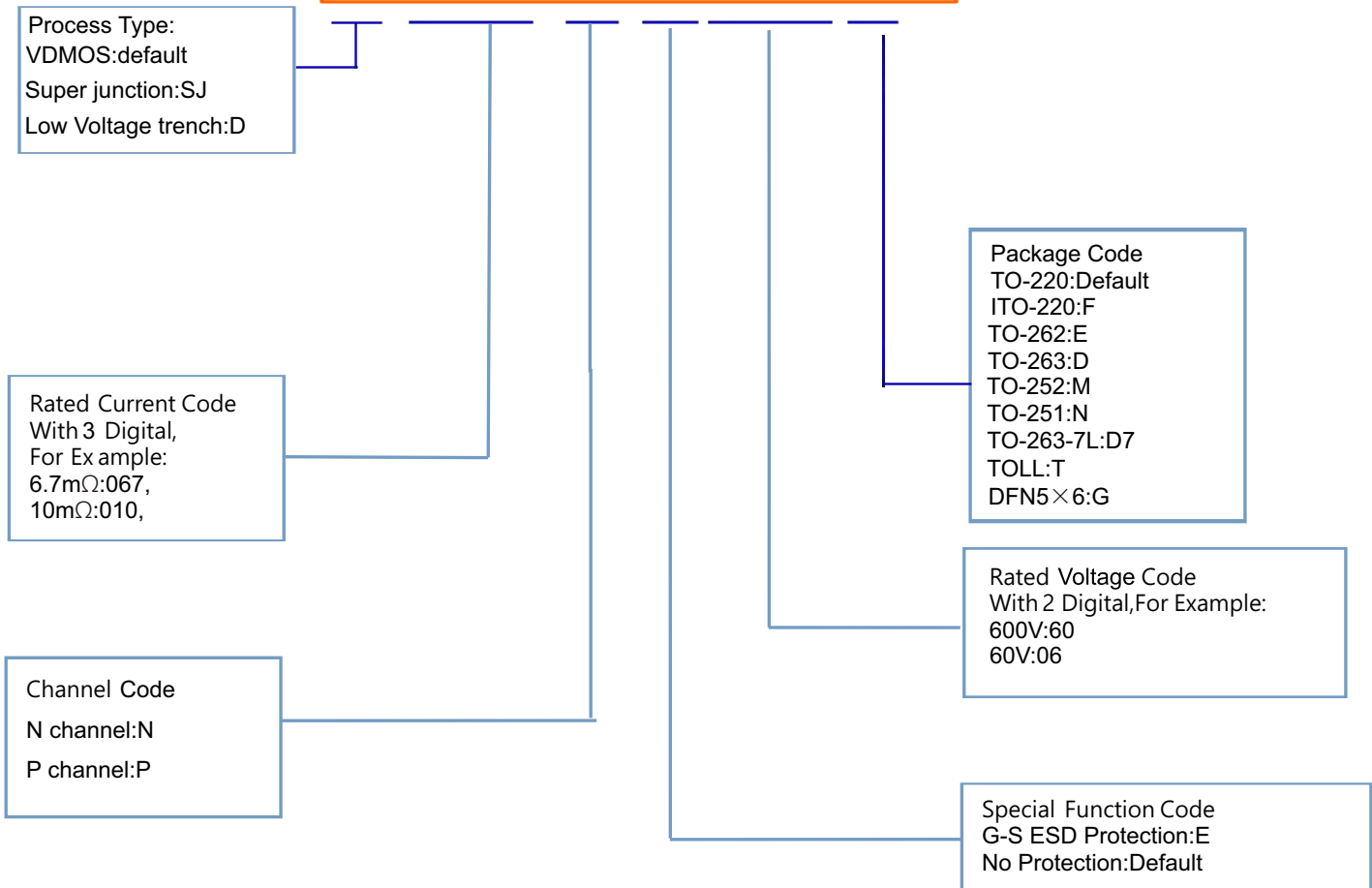
7) . Unclamped Inductive Switching Test Circuit



8) Unclamped Inductive Switching Waveforms

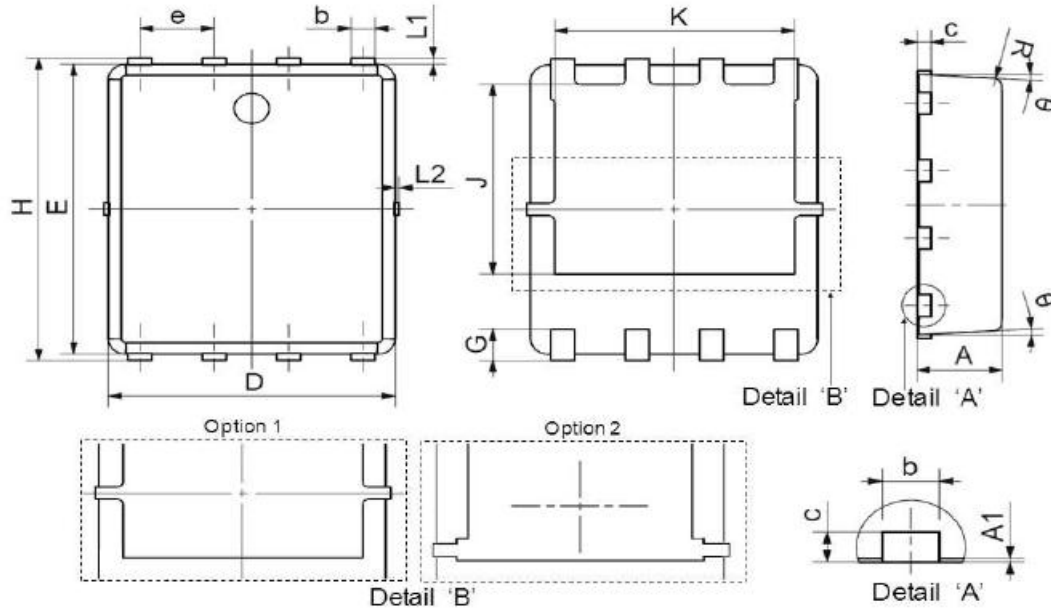
Product Names Rules

X X X X N E X X X



Dimensions

DFN5×6 PACKAGE OUTLINE DIMENSIONS



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0,80	1,20	0,031	0,047
A1	0,00	0,05	0,000	0,002
b	0,30	0,51	0,012	0,020
c	0,15	0,35	0,006	0,014
D	4,80	5,40	0,189	0,213
e	1,27 BSC		0,050 BSC	
E	5,66	6,06	0,223	0,239
G	0,30	0,71	0,012	0,028
H	5,90	6,35	0,232	0,250
J	3,32	3,92	0,131	0,154
K	3,61	4,25	0,142	0,167
L1	0,05	0,25	0,002	0,010
L2	0,00	0,15	0,000	0,006
R	0,25 REF		0,010 REF	
θ	0°	12°	0°	12°



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